


<b>Search Notes</b> 	<b>Application/Control No.</b> 10519747	<b>Applicant(s)/Patent Under Reexamination</b> FUKUI ET AL.
	<b>Examiner</b> Seung H Lee	<b>Art Unit</b> 2887

SEARCHED			
Class	Subclass	Date	Examiner
235	435,487,491,492	7/31/08	sl

SEARCH NOTES		
Search Notes	Date	Examiner
EAST	7/31/08	sl

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner